## Notice of References Cited

Application/Control No. 09/676,924	Applicant(s)/Pater Reexamination COHEN, SHY	nt Under	
Examiner	Art Unit		
Hai V. Nguyen	2142	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0046294	04-2002	Brodsky et al.	709/246
	В	US-6,789,119	09-2004	Zhu et al.	709/227
	С	US-6,725,272	04-2004	Susai et al.	709/229
	D	US-6,650,621	11-2003	Maki-Kullas, Jukka	370/238
	E	US-6,584,321	06-2003	Coan et al.	455/466
	F	US-6,415,027	07-2002	Malik, Dale W.	379/221.01
	G	US-6,411,986	06-2002	Susai et al.	709/203
	Ι	US-6,161,130	12-2000	Horvitz et al.	709/206
	1	US-5,805,804	09-1998	Laursen et al.	709/223
	٦	US-			
	К	US-			
	اد	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	σ					
	R					
	Ø				*	
	T					

## **NON-PATENT DOCUMENTS**

	NON- ATEN BOOMENS				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	٧				
	w				
	x				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

